

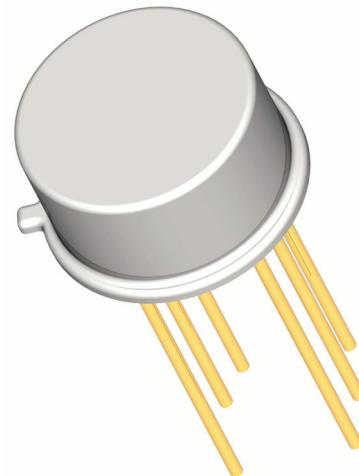
Description

Semicoa Semiconductors offers:

- Screening and processing per MIL-PRF-19500 Appendix E
- JAN level (2N2060J)
- JANTX level (2N2060JX)
- JANTXV level (2N2060JV)
- QCI to the applicable level
- 100% die visual inspection per MIL-STD-750 method 2072 for JANTXV
- Radiation testing (total dose) upon request

Applications

- Matched, Dual Transistors
- Low power
- NPN silicon transistor



Features

- Hermetically sealed TO-77 metal can
- Also available in chip configuration
- Chip geometry 0410
- Reference document: MIL-PRF-19500/270

Benefits

- Qualification Levels: JAN, JANTX, and JANTXV
- Radiation testing available

Absolute Maximum Ratings		$T_c = 25^\circ\text{C}$ unless otherwise specified	
Parameter	Symbol	Rating	Unit
Collector-Emitter Voltage	V_{CEO}	60	Volts
Collector-Base Voltage	V_{CBO}	100	Volts
Emitter-Base Voltage	V_{EBO}	7	Volts
Collector Current, Continuous	I_C	500	mA
Power Dissipation, $T_A = 25^\circ\text{C}$ Derate linearly above 25°C	P_T	540 one section 600 both sections 3.08 one section 3.48 both sections	mW mW $\text{mW}/^\circ\text{C}$ $\text{mW}/^\circ\text{C}$
Power Dissipation, $T_c = 25^\circ\text{C}$ Derate linearly above 25°C	P_T	1.5 one section 2.12 both sections 8.6 one section 12.1 both sections	W W $\text{mW}/^\circ\text{C}$ $\text{mW}/^\circ\text{C}$
Operating Junction Temperature Storage Temperature	T_J T_{STG}	-65 to +200	°C

ELECTRICAL CHARACTERISTICS

characteristics specified at $T_A = 25^\circ\text{C}$

Off Characteristics

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
Collector-Emitter Breakdown Voltage	$V_{(\text{BR})\text{CEO}}$	$I_C = 30 \text{ mA}$	60			Volts
Collector-Emitter Breakdown Voltage	$V_{(\text{BR})\text{CER}}$	$I_C = 10 \text{ mA}, R_{BE} = 10 \Omega$	80			Volts
Collector-Base Cutoff Current	$I_{\text{CBO}1}$ $I_{\text{CBO}2}$ $I_{\text{CBO}3}$	$V_{CB} = 100 \text{ Volts}$ $V_{CB} = 80 \text{ Volts}$ $V_{CB} = 80 \text{ Volts}, T_A = 150^\circ\text{C}$			10 2 10	μA nA μA
Collector-Emitter Cutoff Current	I_{CEO}	$V_{CE} = \text{xx Volts}$				μA
Collector-Emitter Cutoff Current	I_{CEX}	$V_{CE} = \text{xx Volts}, V_{EB} = x \text{ Volts}$				μA
Collector-Emitter Cutoff Current	I_{CES}	$V_{CE} = \text{xx Volts}$				nA
Emitter-Base Cutoff Current	$I_{\text{EBO}1}$ $I_{\text{EBO}2}$	$V_{EB} = 7 \text{ Volts}$ $V_{EB} = 5 \text{ Volts}$			10 2	μA nA

On Characteristics

Pulse Test: Pulse Width = 300 μs , Duty Cycle $\leq 2.0\%$

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
DC Current Gain	h_{FE1} h_{FE2} h_{FE3} h_{FE4} h_{FE5}	$I_C = 10 \mu\text{A}, V_{CE} = 5 \text{ Volts}$ $I_C = 100 \mu\text{A}, V_{CE} = 5 \text{ Volts}$ $I_C = 1 \text{ mA}, V_{CE} = 5 \text{ Volts}$ $I_C = 10 \text{ mA}, V_{CE} = 5 \text{ Volts}$ $I_C = 100 \mu\text{A}, V_{CE} = 5 \text{ Volts}$ $T_A = -55^\circ\text{C}$	25 30 40 50 10		75 90 120 150	
Base-Emitter Voltage Differential	$ V_{BE1} - V_{BE2} _1$ $ V_{BE1} - V_{BE2} _2$	$V_{CE} = 5 \text{ Volts}, I_C = 100 \mu\text{A}$ $V_{CE} = 5 \text{ Volts}, I_C = 1 \text{ mA}$			5	mVolts
Base-Emitter Voltage Differential change with temperature	$ V_{BE1} - V_{BE2} _1$ $ V_{BE1} - V_{BE2} _2$	$V_{CE} = 5 \text{ Volts}, I_C = 100 \mu\text{A}$ $T_A = 25^\circ\text{C} \text{ and } -55^\circ\text{C}$ $V_{CE} = 5 \text{ Volts}, I_C = 1 \text{ mA}$ $T_A = 25^\circ\text{C} \text{ and } +125^\circ\text{C}$.8 1	mVolts

Dynamic Characteristics

Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
Magnitude – Common Emitter, Short Circuit Forward Current Transfer Ratio	$ h_{FE} $	$V_{CE} = 10$ Volts, $I_C = 50$ mA, $f = 20$ MHz	3		25	
Small Signal Short Circuit Forward Current Transfer Ratio	h_{FE}	$V_{CE} = 5$ Volts, $I_C = 1$ mA, $f = 1$ kHz	50		150	
Open Circuit Output Capacitance	C_{OBO}	$V_{CB} = 10$ Volts, $I_E = 0$ mA, 100 kHz < $f < 1$ MHz			15	pF
Open Circuit Input Capacitance	C_{IBO}	$V_{EB} = 0.5$ Volts, $I_C = 0$ mA, 100 kHz < $f < 1$ MHz			85	pF
Noise Figure	NF_1	$V_{CE} = 10$ Volts, $I_C = 300$ μ A, $f = 1$ kHz, $R_g = 510$ Ω			8	dB
	NF_2	$V_{CE} = 10$ Volts, $I_C = 300$ μ A, $f = 10$ kHz, $R_g = 1$ k Ω			8	
Short Circuit Input Impedance	h_{ib}	$V_{CB} = 5V$, $I_C = 1mA$, $f = 1kHz$	20		30	Ω
Short Circuit Input Impedance	h_{ie}	$V_{CB} = 5V$, $I_C = 1mA$, $f = 1kHz$	1		4	k Ω
Open Circuit Output Admittance	h_{oe}	$V_{CB} = 5V$, $I_C = 1mA$, $f = 1kHz$			16	μ mhos